Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,869	FLORKEY ET AL.	
Examiner	Art Unit	
DANH C. LE	2617	

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search ((hech for double patenting) EAS Bearch (US, USPUB)	5 17 06	DC1_		